



No. 23T04Z70647-008



The Photos of SAR test

No. 23T04Z70647-008

For

Samsung Electronics Co., Ltd.

Notebook PC

Model name:

**NP750XGL, NP750XGP, NP751XGL, NP751XGP, NP754XGL, NP754XGP,
NP750XGK, NP750XGQ, NP754XGK, NP751XGK, NP751XGQ, NP754XGQ**

With

Hardware Version: REV1.0

Software Version: Windows11

FCC ID: ZCANP750XGL

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S. Government.

Test Laboratory:

CTTL, Telecommunication Technology Labs, CAICT

No. 52, Huayuan North Road, Haidian District, Beijing, P. R. China 100191.

Tel: +86(0)10-62304633-2512, Fax: +86(0)10-62304633-2504

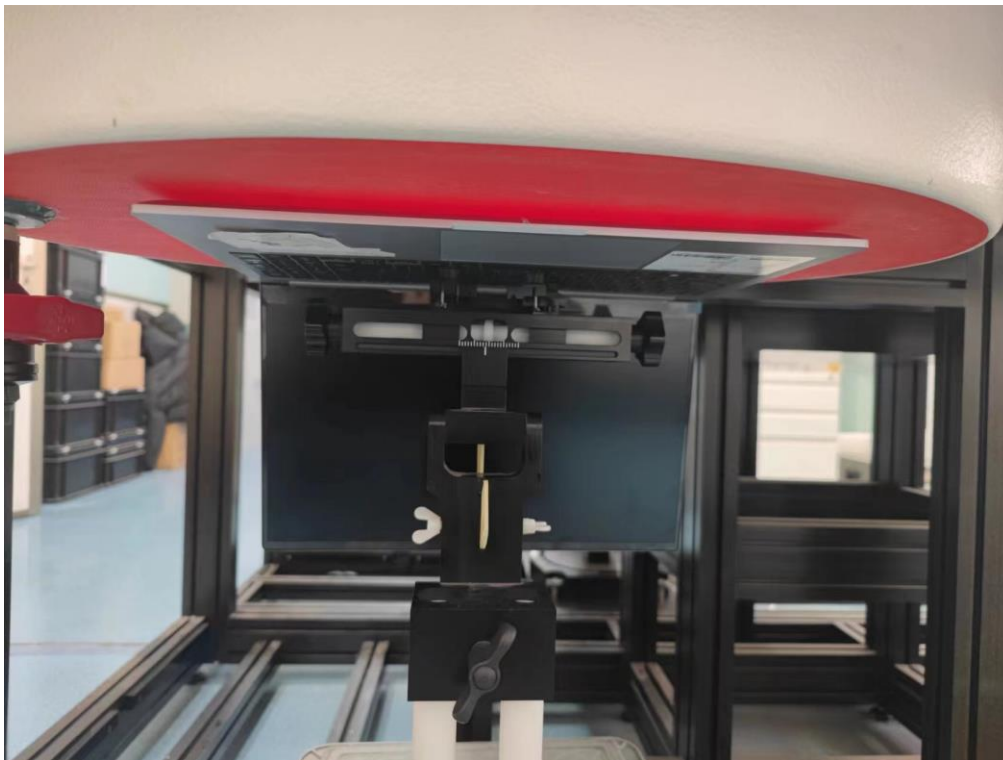
Email: ctl_terminals@caict.ac.cn, website: www.caict.ac.cn



Picture 1: Constituents of the sample

Test positions for body:

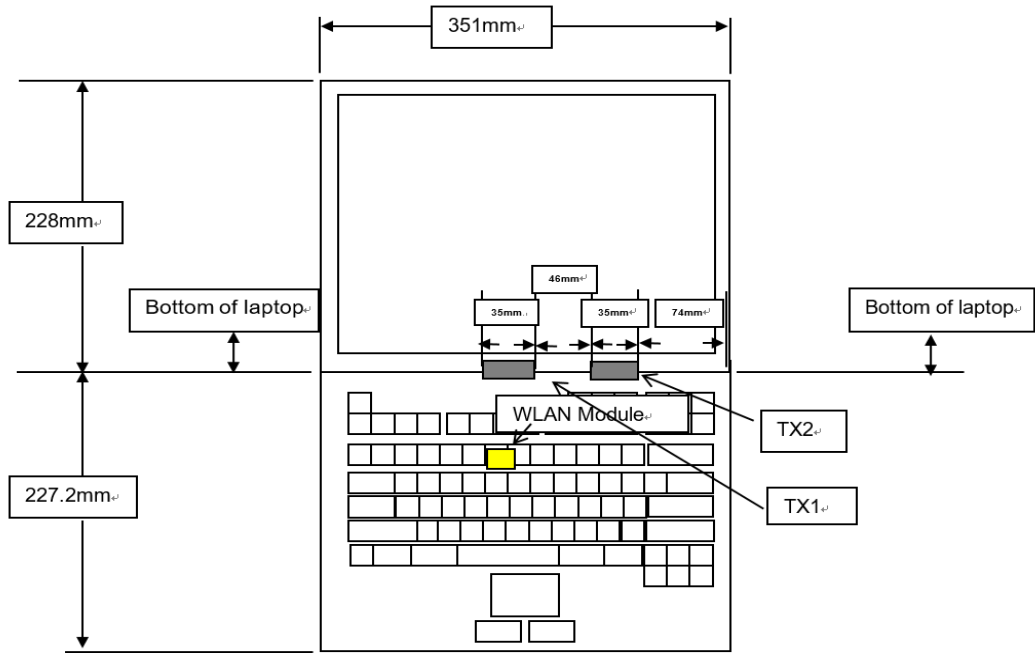
The Body SAR is tested at the following 2 test positions all with the distance =0mm between the EUT and the phantom bottom:



Picture 2 Rear 0mm



Picture 3 Front 0mm



Picture 4 Antenna Locations